

# **30V N-ch Power MOSFET**

### **General Features**

- Proprietary New Trench Technology
- $\triangleright$  R<sub>DS(ON),typ.</sub>=4.0m $\Omega$ @V<sub>GS</sub>=10V
- Low Gate Charge Minimize Switching Loss
- Fast Recovery Body Diode

## **Applications**

- High efficiency DC/DC Converters
- Synchronous Rectification
- UPS Inverter

# Ordering Information

Part Number	Package	Marking		
FTP30N5P4L	TO-220-3L	30N5P4L		
FTB30N5P4L	TO-263-2L	30N5P4L		

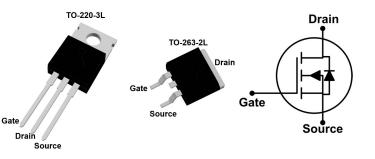
## **Absolute Maximum Ratings**

Symbol	Parameter	Value	Unit	
V <sub>DSS</sub>	Drain-to-Source Voltage <sup>[1]</sup>	30	- V	
V <sub>GSS</sub>	Gate-to-Source Voltage	±20		
I <sub>D</sub>	Continuous Drain Current	94		
ID	Continuous Drain Current at T_c=100 $^\circ\!\mathrm{C}$	67	A	
I <sub>DM</sub>	Pulsed Drain Current at V <sub>GS</sub> =10V <sup>[2]</sup>	378	7	
E <sub>AS</sub>	Single Pulse Avalanche Energy (V <sub>DD</sub> =15V, V <sub>GS</sub> =10V, R <sub>G</sub> =25Ω, L=1mH)	128	mJ	
PD	Power Dissipation	90	W	
	Derating Factor above 25°C	0.60	W/°C	
TL	Soldering Temperature Distance of 1.6mm from case for 10 seconds	300	°C	
T <sub>J</sub> & T <sub>STG</sub> Operating and Storage Temperature Range		-55 to 175	C	

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" may cause permanent damage to the device.

## **Thermal Characteristics**

Symbol	Parameter	Min.	Тур.	Max.	Unit
R <sub>θJC</sub>	Thermal Resistance, Junction-to-Case			1.7	°C AA
R <sub>0JA</sub>	Thermal Resistance, Junction-to-Ambient			63	°C/W



 $T_C {=} 25^\circ\!\mathrm{C}$  unless otherwise specified



# **Electrical Characteristics**

#### **OFF** Characteristics

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
BV <sub>DSS</sub>	Drain-to-Source Breakdown Voltage	30		maxi	V	$V_{GS}$ =0V, I <sub>D</sub> =250uA	
		00		1	uA	V <sub>DS</sub> =24V, V <sub>GS</sub> =0V	
	Drain-to-Source Leakage Current						
I <sub>GSS</sub>	Gate-to-Source Leakage Current racteristics			±100	nA	V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V 5℃ unless otherwise specifie	
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
Symbol							
	Static Drain-to-Source On-Resistance		4.0	5.4	mΩ	V <sub>GS</sub> =10V, I <sub>D</sub> =80A <sup>[3]</sup>	
			6.1	8.5	mΩ	$V_{GS}$ =4.5V, $I_{D}$ =47A <sup>[3]</sup>	
V <sub>GS(TH)</sub>	Gate Threshold Voltage	1.0		3.0	V	$V_{DS} = V_{GS}$ , $I_D = 250 uA$	
Dynami	c Characteristics		E	Essentiall	y indeper	ndent of operating temperatur	
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
Ciss	Input Capacitance		1.1			V <sub>GS</sub> =0V,	
Crss	Reverse Transfer Capacitance		0.12		nF	V <sub>DS</sub> =25V,	
Coss	Output Capacitance		0.24			f=1.0MHz	
R <sub>g</sub>	Gate Series Resistance		3.1		Ω	f=1.0MHz	
Qg	Total Gate Charge		12			V <sub>DD</sub> =15V, I <sub>D</sub> =80A, V <sub>GS</sub> =4.5V	
0			23		nC		
Q <sub>gs</sub>	Gate-to-Source Charge		3.6			V <sub>DD</sub> =15V, I <sub>D</sub> =80A, V <sub>GS</sub> =10V	
Q <sub>gd</sub>	Gate-to-Drain (Miller) Charge		4.7				
Resistiv	e Switching Characteristics	1		Essential	ly indepe	ndent of operating temperatu	
Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	
t <sub>d(on)</sub>	Turn-on Delay Time		6.9			V <sub>DD</sub> =15V	
t <sub>rise</sub>	Rise Time		1.9			$I_{D}=80A$ $V_{GS}=4.5V$ $R_{G}=2.5\Omega$	
t <sub>d(off)</sub>	Turn-off Delay Time		24		ns		
t <sub>fall</sub>	Fall Time		4.7				
Source-	Drain Body Diode Characteristic	cs	1	1	TJ=2	$5^{\circ}$ C unless otherwise specific	
Symbol	Parameter	Min	Тур.	Max.	Unit	Test Conditions	
I <sub>SD</sub>	Continuous Source Current <sup>[2]</sup>			94	Α	Maximum Ratings	
V <sub>SD</sub>	Diode Forward Voltage		0.9	1.2	V	I <sub>S</sub> =80A, V <sub>GS</sub> =0V	
t <sub>rr</sub>	Reverse Recovery Time		8.5		ns	V <sub>GS</sub> =0V	
Q <sub>rr</sub>	Reverse Recovery Charge		1.9		nC	I <sub>F</sub> =20A,di/dt=100A/µs	

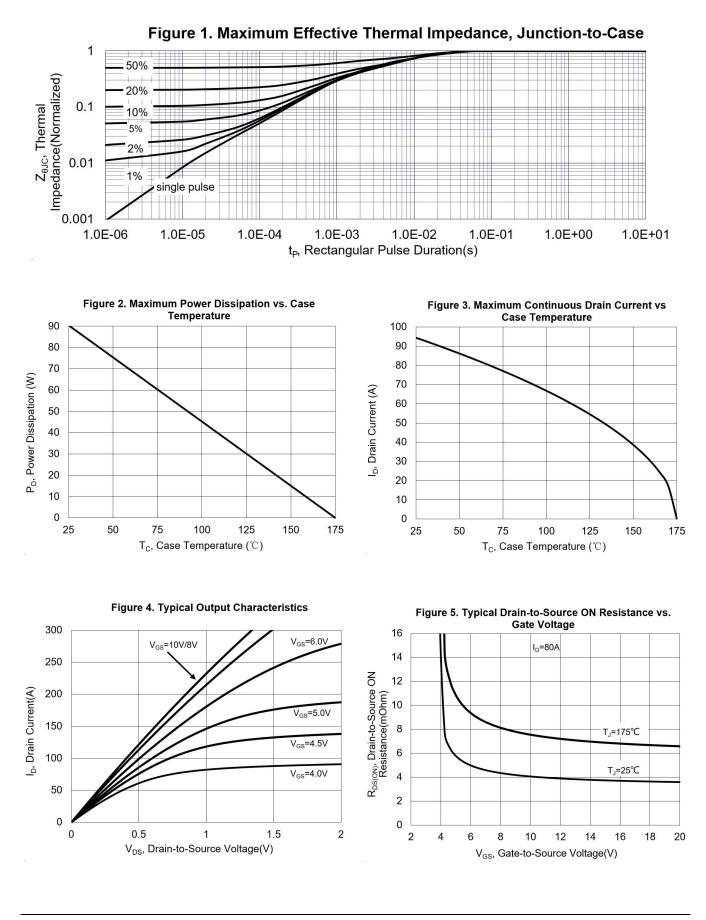
Note:

[1] T<sub>J</sub>=25℃ to 175℃

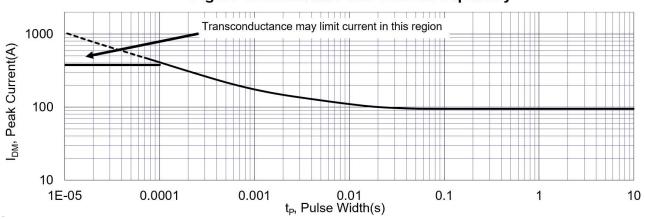
[2] Repetitive rating, pulse width limited by maximum junction temperature.

[3] Pulse width≤380µs; duty cycle≤2%.

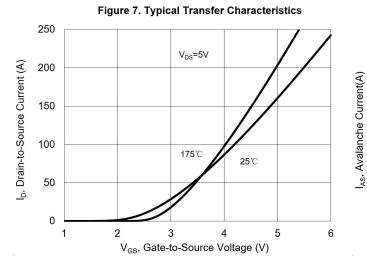


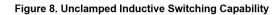


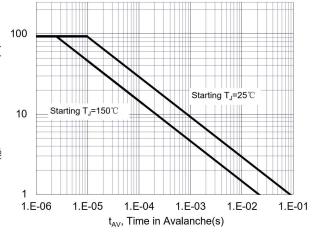


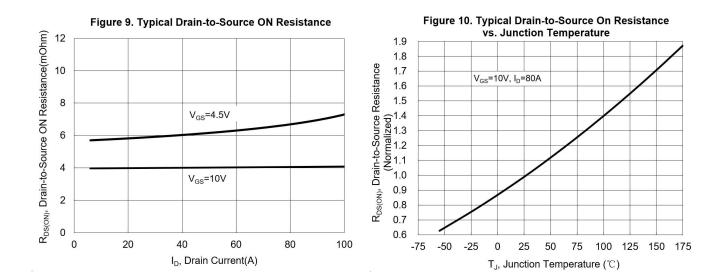




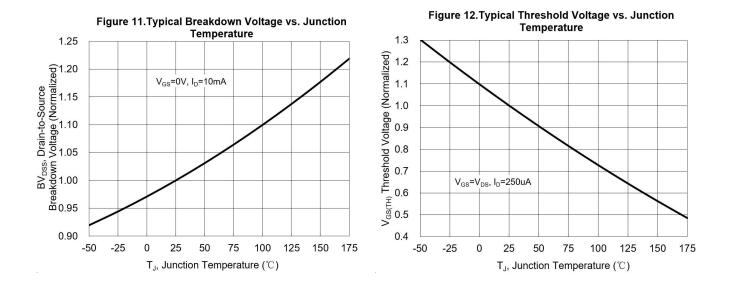




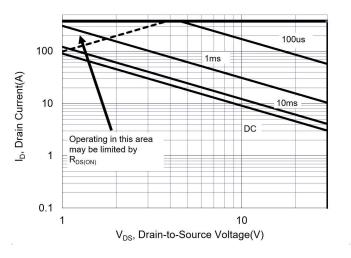




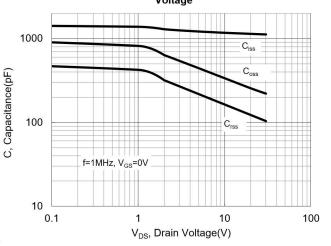


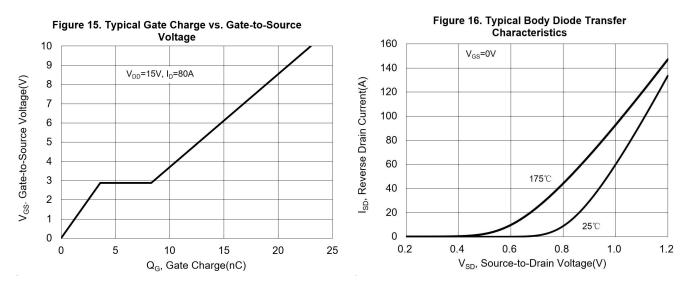












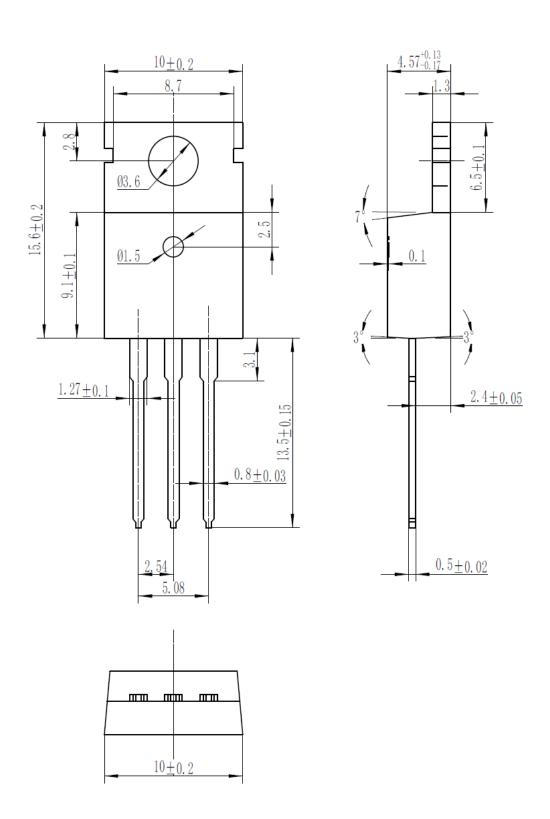
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FTP30N5P4L, FTB30N5P4L

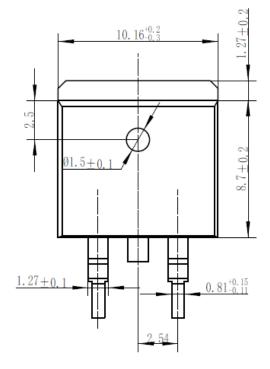
# Package Dimensions

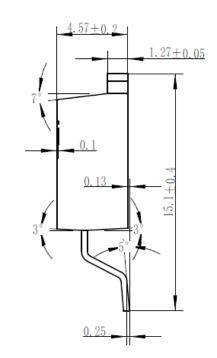
TO-220-3L

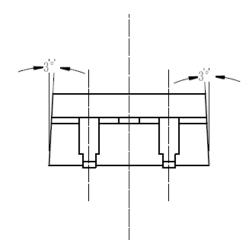




# TO-263-2L









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